

# **Notice of References Cited**

Application/Control No.

09/633,098

Applicant(s)/Patent Under  
Reexamination  
SHIRAISHI ET AL.

Examiner

Steven H. Rao

Art Unit

2814

Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,457,862 ✓	10-1995	Sakata et al.	29/25.03
	B	US-5,473,503 ✓	12-1995	Sakata et al.	361/523
	C	US-5972052 ✓	10-1999	Kobayayshi et al.	29/ 25.03
	D	US-6,191,013 ✓	02-2001	Hahn et al.	438/396
	E	US-6,239,965 ✓	05-2001	Shiraishi et al.	361/508
	F	US-6,310,765 ✓	10-2001	Tanahashi et al.	361/503
	G	US-6,334,966 ✓	01-2002	Hahn et al.	252/500
	H	US-6,352,564 ✓	03-2002	Araki et al.	29/25.03
	I	US-6,409,905 ✓	06-2002	Melody et al.	205/234
	J	US-6,413,282 ✓	07-2002	Tanahashi et al.	29/25.03
	K	US-			
	L	US-			
	M	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EPA 0559109A1	08-1993	European Patent	Inaba Akira	
	O	JP 02000 23,202A	08-2000	Japan	H. Kenji et al.	
	P					
	Q					
	R					
	S					
	T					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.